

EAST Search History

EAST Search History (Prior Art)

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	93	("20060144423" "6011405" "6246250" "5861759" "6268739" "6288559" "7405584" "6130546" "5829128" "5832601" "5864946" "5878486" "5884398" "5897326" "5974662" "5983493" "5998228" "6032356" "6050829" "6246247" "7122829" "20050099862" "20060113535" "5469072" "6121058" "6143668" "6246245" "6300786" "6337577" "6366112" "6049216" "5585737" "5914613" "6034533" "6307387" "6437584" "7061263" "7230439" "20060149505" "6856156" "20040189332" "5534784" "6427222" "4980637" "7259579" "20030102878" "20060186907" "5239260" "6777971" "6870382").pn.	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L3	318	((probe or pin or needle) near3 clean\$4) and 324/754-765,158.1. ocls.	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L12	6	("3881964" "4197632" "4440799" "6087895" "6265245" "6320397").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21

L15	83	"15"/\$.ccls. and "324"/\$.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L16	36	("2800215" "20030200989" "20050001645" "3148404" "4590422" "5220279" "5813081" "5968282" "5998986" "6037793" "6057694" "6118289" "6118289" "6118290" "6127831" "6130104" "6777966").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L17	113	soc and spindle and motor and read/write and (hard near3 disk) and controller and memory	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L19	16	(probe near3 card) and test\$4 and die and wafer and ((probe or needle or contact) near8 fail\$4 near8 contact\$4 near8 (pad or electrode)) and clean \$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L20	270	((probe or needle or contact) near8 fail\$4 near8 contact\$4 near8 (pad or electrode)) and clean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L21	36	((probe or needle or contact) near8 fail\$4 near8 contact\$4 near8 (pad or electrode)) same clean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L22	34	L21 not L19	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L23	38	((probe or needle or contact) near8 ((fail\$4 or wrong or declin\$4) near8 (contact\$4 or touch\$4)) near8 (pad or electrode)) same clean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L24	288	((probe or needle or contact) near8 ((fail\$4 or wrong or declin\$4) near8 (contact\$4 or touch\$4)) near8 (pad or electrode)) and clean \$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L25	17	L24 and 324/754-765,158.1.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L27	3	L24 and "134"/\$.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L32	6	((probe or needle or contact) near8 (report \$4 or notify\$4) near8 ((fail\$4 or wrong or declin\$4) near8 (contact \$4 or touch\$4)) near8 (pad or electrode)) sameclean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L33	6	((probe or needle or contact) near8 (report \$4 or notify\$4) near8 ((fail\$4 or wrong or declin\$4 or "not") near8 (contact\$4 or touch\$4)) near8 (pad or electrode)) sameclean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L34	3	((probe or needle or contact) near8 (report \$4 or notify\$4) near8 ((fail\$4 or wrong or declin\$4 or "not") near8 (contact\$4 or touch\$4)) near8 (pad or electrode)) same clean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L35	3	((probe or needle or contact) near8 (report \$4 or notify\$4) near8 ((fail\$4 or wrong or declin\$4 or "not") near8 (contact\$4 or touch\$4)) near8 (pad or electrode)) and clean \$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L37	277	((probe or needle or contact) near8 (fail\$4 or wrong or declin\$4 or "not") near8 (contact\$4 or touch\$4) near8 (pad or electrode)) and clean \$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L38	36	((probe or needle or contact) near8 (fail\$4 or wrong or declin\$4 or "not") near8 (contact\$4 or touch\$4) near8 (pad or electrode)) same clean\$5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L42	2	JP near2 "2004085377"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L43	2	JP near2 "2002147197"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L44	2	"6927078".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L45	42	("3881964" "4197632" "4440799" "6087895" "6265245" "6320397").PN. OR ("6927078").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L46	76	("5127473").PN. OR ("5666063").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21

L48	7	(fail\$4 near8 (electrical \$5 near3 contact\$4) near8 pad\$2) same clean\$5	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L49	15	(fail\$4 near8 contact\$4 near8 pad\$2) same clean\$5	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L50	8	L49 not L48	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L51	1140	(probe or needle or pin) near8 fail\$4 near8 (contact\$4 or touch\$4)	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L52	53	((probe or needle or pin) near8 fail\$4 near8 (contact\$4 or touch\$4)) same (clean\$4 or debris)	US-PGPUB; USPAT; USOCR	OR	ON	2009/09/11 21:21
L53	223	((probe or needle or pin) near8 fail\$4 near8 (contact\$4 or touch\$4)) and (clean\$4 or debris)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L54	560	((probe or needle or pin) near8 (fail\$4 or "not" or mak\$3) near8 (contact\$4 or touch\$4)) same (clean\$4 or debris)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L55	48	L53 and 324/754-762. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L56	80	L54 and 324/754-762. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L57	66	L56 not L55	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L62	3263	(probe adj card) near8 test\$4 near8 (dies or wafer)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L63	519	L62 and (contact near3 resistance)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L64	315	L63 and 324/754-765. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L65	59	((probe adj card) near8 test\$4 near8 (dies or wafer)) same (contact near3 resistance)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L66	35	L65 and 324/754-765. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L69	26035	tester near8 control\$4 nea8 (probe near3 card)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L70	2317	L69 and 324/754. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L71	298	L70 and clean\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L72	121	tester near8 control\$4 near8 (probe near3 card)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L73	52	L72 and 324/754.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L74	5	tester near8 (probe near4 test) near8 (pass and fail)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L75	2	(test near6 fail\$4) near8 (skip near4 die)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L76	3	fail\$4 near8 (skip near4 die)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L77	6	fail\$4 near8 (skip\$4 near4 die)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L78	24	fail\$4 near8 (skip\$4 near4 (die or ic or chip or dut))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L79	0	if near5 test near5 fail \$4 near8 (skip\$4 near4 (die or ic or chip or dut))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L80	0	if near5 test near5 fail \$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L82	50	(test near8 (fail\$4 or bad or reject\$4) near8 (die or chip or ic or dut)) same (skip\$4 or omit\$4 or (pass\$3 adj up))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L83	0	re\$prob\$4 near5 (die or dut or ic or chip) near8 ("not" near4 skip \$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L84	1	re\$prob\$4 near5 (die or dut or ic or chip) near8 (skip\$4 or omit \$4 or (pass\$3 adj up))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L85	1	re\$prob\$4 near5 (die or dut or ic or chip) same (skip\$4 or omit\$4 or (pass\$3 adj up))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L86	45	re\$prob\$4 near5 (die or dut or ic or chip)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L87	29	L86 and "324"/\$.ocls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L88	585	(re\$prob\$4 or ((repeat \$4 or again) near6 prob \$4)) near5 (die or dut or ic or chip)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L89	189	L88 and "324"/\$.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L90	19	(re\$prob\$4 or ((repeat \$4 or again) near6 prob \$4)) near5 (die or dut or ic or chip) near8 (fail \$4 or bad or reject\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L92	9	re\$prob\$4 near8 (die or dut or ic or chip) near8 (fail\$4 or bad or reject\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L93	47	re\$prob\$4 near8 (die or dut or ic or chip)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L94	29	L93 and "324"/\$.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L95	47	(re\$prob\$4 or reprob \$4) near8 (die or dut or ic or chip)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L96	18	L93 not L94	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L97	2	(number near3 (die\$2 or ic or chip or dut or (integrat\$4 near3 circuit \$3) or (device adj under adj test))) near8 clean\$4 near8 (exceed \$4 or above or greater)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L98	4	((number or quantity) near4 (die\$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test))) near8 clean\$4 near8 (exceed\$4 or above or greater or excel\$4 or beyond or outreach\$3 or transcend\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L99	689	((die\$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test)) near8 clean\$4 near8 (exceed\$4 or above or greater or excel\$4 or beyond or outreach\$3 or transcend\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L100	10	L99 and 324/754-765. ocls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L101	100	L99 and "134"/\$.ocls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L102	66	((die\$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test)) near8 clean\$4 near8 (exceed\$4 or above or greater or excel\$4 or beyond or outreach\$3 or transcend\$3)) same prob\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L103	16	L102 and "134"/\$.ocls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L105	517	(maximum or predetermin\$4 or set\$3 or desir\$3) near8 (die \$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test)) near8 clean\$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L106	29	(maximum or predetermin\$4 or set\$3 or desir\$3) near8 (die \$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test)) near8 clean\$4 near8 (exceed\$4 or above or greater or excel\$4 or beyond or outreach\$3 or transcend\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L107	277	(die\$2 or ic or chip or dut or (integrat\$4 near3 circuit\$3) or (device adj under adj test)) near8 fail\$4 near8 test near8 voltage	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L108	120	L107 and 324/754-765.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L113	609	324/754-762.ccls. and ((electrical near4 characteristic) near8 (probe or needle))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L114	15	324/754-762.ccls. and ((electrical near4 characteristic) near8 (probe or needle) near8 voltage)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L115	39	"324"/\$.ccls. and ((electrical near4 characteristic) near8 (probe or needle) near8 voltage)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L116	24	L115 not L114	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L117	119	"324"/\$.ccls. and (((electrical near4 characteristic) near8 (probe or needle)) same voltage)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L118	80	L117 not L115	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L119	11	("20030210033" "20040041581" "5355079" "6239590" "6927078" "7285969").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L121	527	324/754-762.ccls. and ((electrical near4 characteristic) near5 (probe or needle))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L122	58	L121 and 324/762.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L127	3417	((measur\$4 near3 voltage) near5 (probe or needle))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L128	144	L127 and 324/754-762. ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21

L130	110	((measur\$4 near8 (voltage and (contact near3 resistance))) near8 (probe or needle))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:21
L135	26374	tan.in.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:38
L136	16	135 and (probe adj card) and test	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:39
L137	6	135 and (probe adj card) and test and die and fail	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/09/11 21:39

EAST Search History (Interference)

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L138	4927	324/765.ccls.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:40
L139	0	138 and (probe near3 card) and die and wafer and fail\$4 and (electrical\$4 near3 characteristic) and (predetermin\$4 near3 value) and tester and re \$prob\$4 and skip\$4 and maximum and clean \$4. cm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L140	0	138 and die and wafer and fail\$4 and (electrical\$4 near3 characteristic) and (predetermin\$4 near3 value) and tester and re \$prob\$4 and skip\$4 and maximum and clean \$4. cm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42

L141	0	138 and fail\$4 and (electrical\$4 near3 characteristic) and (predetermin\$4 near3 value) and tester and re \$prob\$4 and skip\$4 and maximum and clean \$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L142	0	138 and fail\$4 and (predetermin\$4 near3 value) and tester and re \$prob\$4 and skip\$4 and maximum and clean \$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L143	0	138 and fail\$4 and tester and re\$prob\$4 and skip\$4 and maximum and clean\$4. clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L144	0	138 and fail\$4 and re \$prob\$4 and skip\$4 and maximum and clean \$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L145	0	138 and fail\$4 and re \$prob\$4 and skip\$4 and clean\$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:42
L146	0	138 and re\$prob\$4 and skip\$4 and clean\$4. clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:43
L147	0	138 and re\$prob\$4 and clean\$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:43
L148	2	138 and re\$prob\$4. clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:43
L149	2	138 and (re\$prob\$4 or reprob\$4). clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:43
L150	0	138 and skip\$4 and clean\$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:44
L151	29	138 and clean\$4.clm.	US-PGPUB; USPAT; UPAD	OR	ON	2009/09/11 21:44

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